

The preliminary amendment is being presented to make certain stylistic changes.

Please charge any other fees which might be due with respect to Sections 1.16 and 1.17 to the Deposit Account of Lerner & Greenberg P.A., No. 12-1099.

Respectfully submitted,

For Applicant(s)

AKD:cgm

RALPH E. LOCHER REG. NO. 41,947

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Lerner and Greenberg, P.A. Post Office Box 2480 Hollywood, FL 33022-2480

Tel: (954) 925-1100 Fax: (954) 925-1101

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Marked-up version of the claims:

Claim 13 (amended). A method for producing [an] electronic [component] components with shielding, which comprises the steps of:

providing a semiconductor wafer functioning as a semiconductor substrate formed of a semiconductor material and having an active upper side for at least one integrated circuit <u>for each</u> of the electronic components and a passive rear side;

implanting impurities from the passive rear side of the semiconductor wafer for forming a buried layer being electrically conductive and having a surface area corresponding in size to a surface area of the passive rear side of the semiconductor substrate;

introducing an electrically conductive annular layer <u>for each</u>
of the electronic components from the active upper side of the
semiconductor wafer as far as the buried layer in an edge
region of the integrated circuit;

producing the integrated circuit within the electrically conductive annular layer for each of the electronic components

in the semiconductor substrate defining a semiconductor chip for each of the electronic components; and

packaging the semiconductor chip to form the electronic [component] components with the shielding.

Claim 21 (amended). A method for producing [an] electronic [component] components with shielding, which comprises the following steps:

providing a semiconductor wafer functioning as a semiconductor substrate having an active upper side for at least one integrated component <u>for each of the electronic components</u> and a passive rear side;

growing an electrically conductive layer formed of an electrically conductive semiconductor material and thereafter an electrically intrinsically conductive layer formed of an electrically intrinsic conductive semiconductor material on the active upper side of the semiconductor wafer by epitaxial growth, the electrically conductive layer becoming a buried layer adjacent the electrically intrinsically conductive layer;

introducing an electrically conductive annular layer <u>for each</u> of the <u>electronic</u> components from the active upper side of the

semiconductor wafer, the electrically conductive annular layer extending through the electrically intrinsically conductive layer as far as the buried layer, the electrically conductive annular layer disposed in an edge region of the semiconductor substrate;

producing the integrated circuit within the electrically conductive annular layer <u>for each of the electronic components</u> in the semiconductor substrate defining a semiconductor chip; and

packaging the individual conductor chips to form the electronic [component] components with the shielding.